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	Docket No.: 42P13639I
JUN 2 2 2006 IN THE UNITED STATES PATENT	AND TRADEMARK OFFICE
RIDEMAN	\
In re Application of:))
Andrew J. Kuzma	Examiner: Jennifer M. Dolan
Application No.: 10/659,898)) Art Unit: 2813)
Filed: September 11, 2003)
For: WAFER-LEVEL TEST STRUCTURE FOR EDGE-EMITTING SEMICONDUCTOR LASERS)))
Mail Stop Issue Fee Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450	
SUBMISSION OF REPLACE	EMENT DRAWINGS
Sir:	
Submitted herewith are replacement drawing	s, Figures 1-9 (6 sheets). No new matter has
been added. Applicants respectfully request approva	l of the enclosed replacement drawings for
the above-identified application.	
Respectfully su	bmitted,
BLAKELY SO	KOLOFF TAYLOR & ZAFMAN, LLP
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Date: 6-20-06	
FIRST CLASS CERTIFICA	TE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage in an envelope addressed to Mail Stop Issue Fee, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450

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